Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/644,576	SANCHEZ ET AL.
Examiner	Art Unit
Yong S. Chong	1617

SEARCHED					
Class	Subclass	Date	Examiner		
514	469	6/15/2005	YSC		
558	422	6/15/2005	YSC		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor (EAST, PALM)	6/15/2005	YSC
Text (EAST, STN)	6/15/2005	YSC
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